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### Understanding **Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### **Details**

Product Status	Active
Number of LABs/CLBs	25475
Number of Logic Elements/Cells	326080
Total RAM Bits	16404480
Number of I/O	500
Number of Gates	-
Voltage - Supply	0.97V ~ 1.03V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	900-BBGA, FCBGA
Supplier Device Package	900-FCBGA (31x31)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc7k325t-2ffg900i">https://www.e-xfl.com/product-detail/xilinx/xc7k325t-2ffg900i</a>

Table 1: Absolute Maximum Ratings (1) (Cont'd)

Symbol	Description	Min	Max	Units
I <sub>DCIN</sub>	DC input current for receiver input pins DC coupled V <sub>MGTAVTT</sub> = 1.2V	–	14	mA
I <sub>DCOUT</sub>	DC output current for transmitter pins DC coupled V <sub>MGTAVTT</sub> = 1.2V	–	14	mA
<b>XADC</b>				
V <sub>CCADC</sub>	XADC supply relative to GNDADC	–0.5	2.0	V
V <sub>REFP</sub>	XADC reference input relative to GNDADC	–0.5	2.0	V
<b>Temperature</b>				
T <sub>STG</sub>	Storage temperature (ambient)	–65	150	°C
T <sub>SOL</sub>	Maximum soldering temperature for Pb/Sn component bodies (6)	–	+220	°C
	Maximum soldering temperature for Pb-free component bodies (6)	–	+260	°C
T <sub>j</sub>	Maximum junction temperature(6)	–	+125	°C

**Notes:**

- Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.
- The lower absolute voltage specification always applies.
- For I/O operation, refer to [UG471: 7 Series FPGAs SelectIO Resources User Guide](#).
- The maximum limit applied to DC and AC signals.
- For maximum undershoot and overshoot AC specifications, see [Table 4](#) and [Table 5](#).
- For soldering guidelines and thermal considerations, see [UG475: 7 Series FPGA Packaging and Pinout Specification](#).

Table 2: Recommended Operating Conditions (1)

Symbol	Description	Min	Typ	Max	Units
<b>FPGA Logic</b>					
V <sub>CCINT</sub> <sup>(2)</sup>	Internal supply voltage	0.97	1.00	1.03	V
	For -2L (0.9V) devices: internal supply voltage	0.87	0.90	0.93	V
V <sub>CCBRAM</sub> <sup>(2)</sup>	Block RAM supply voltage	0.97	1.00	1.03	V
	For -2L (0.9V) devices: block RAM supply voltage	0.87	0.90	1.03	V
V <sub>CCAUX</sub>	Auxiliary supply voltage	1.71	1.80	1.89	V
V <sub>CCO</sub> <sup>(3)(4)</sup>	Supply voltage for 3.3V HR I/O banks	1.14	–	3.465	V
	Supply voltage for 1.8V HP I/O banks	1.14	–	1.89	V
V <sub>CCAUX_IO</sub>	Auxiliary supply voltage when set to 1.8V	1.71	1.80	1.89	V
	Auxiliary supply voltage when set to 2.0V	1.94	2.00	2.06	V
V <sub>IN</sub> <sup>(5)</sup>	I/O input voltage	–0.20	–	V <sub>CCO</sub> + 0.2	V
	I/O input voltage for V <sub>REF</sub> and differential I/O standards	–0.20	–	2.625	V
I <sub>IN</sub> <sup>(6)</sup>	Maximum current through any pin in a powered or unpowered bank when forward biasing the clamp diode.	–	–	10	mA
V <sub>CCBATT</sub> <sup>(7)</sup>	Battery voltage	1.0	–	1.89	V
<b>GTX Transceiver</b>					
V <sub>MGTAVCC</sub> <sup>(8)</sup>	Analog supply voltage for the GTX transceiver QPLL frequency range ≤ 10.3125 GHz <sup>(9)(10)</sup>	0.97	1.0	1.08	V
	Analog supply voltage for the GTX transceiver QPLL frequency range > 10.3125 GHz	1.02	1.05	1.08	V
V <sub>MGTAVTT</sub> <sup>(8)</sup>	Analog supply voltage for the GTX transmitter and receiver termination circuits	1.17	1.2	1.23	V
V <sub>MGTVCaux</sub> <sup>(8)</sup>	Auxiliary analog QPLL voltage supply for the transceivers	1.75	1.80	1.85	V

**Table 7** shows the minimum current, in addition to  $I_{CCQ}$ , that are required by Kintex-7 devices for proper power-on and configuration. If the current minimums shown in **Table 6** and **Table 7** are met, the device powers on after all five supplies have passed through their power-on reset threshold voltages. The FPGA must not be configured until after  $V_{CCINT}$  is applied.

Once initialized and configured, use the XPower tools to estimate current drain on these supplies.

**Table 7: Power-On Current for Kintex-7 Devices**

Device	$I_{CCINTMIN}$	$I_{CCAUXMIN}$	$I_{CCOMIN}$	$I_{CCAUX\_IOMIN}$	$I_{CCBRAMMIN}$	Units
	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	
XC7K70T	$I_{CCINTQ} + 450$	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 40$	mA
XC7K160T	$I_{CCINTQ} + 550$	$I_{CCAUXQ} + 50$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 40$	mA
XC7K325T	$I_{CCINTQ} + 600$	$I_{CCAUXQ} + 80$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 40$	mA
XC7K355T	$I_{CCINTQ} + 1450$	$I_{CCAUXQ} + 109$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 81$	mA
XC7K410T	$I_{CCINTQ} + 1500$	$I_{CCAUXQ} + 125$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 90$	mA
XC7K420T	$I_{CCINTQ} + 2200$	$I_{CCAUXQ} + 180$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 108$	mA
XC7K480T	$I_{CCINTQ} + 2200$	$I_{CCAUXQ} + 180$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 108$	mA

**Notes:**

1. Typical values are specified at nominal voltage, 25°C.
2. Use the XPower Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate maximum power-on currents.

**Table 8: Power Supply Ramp Time**

Symbol	Description	Conditions	Min	Max	Units
$T_{VCCINT}$	Ramp time from GND to 90% of $V_{CCINT}$		0.2	50	ms
$T_{VCCO}$	Ramp time from GND to 90% of $V_{CCO}$		0.2	50	ms
$T_{VCCAUX}$	Ramp time from GND to 90% of $V_{CCAUX}$		0.2	50	ms
$T_{VCCAUX\_IO}$	Ramp time from GND to 90% of $V_{CCAUX\_IO}$		0.2	50	ms
$T_{VCCBRAM}$	Ramp time from GND to 90% of $V_{CCBRAM}$		0.2	50	ms
$T_{VCCO2VCCAUX}$	Allowed time per power cycle for $V_{CCO} - V_{CCAUX} > 2.625\text{V}$	$T_J = 100^\circ\text{C}^{(1)}$	–	500	ms
		$T_J = 85^\circ\text{C}^{(1)}$	–	800	
$T_{MGTAVCC}$	Ramp time from GND to 90% of $V_{MGTAVCC}$		0.2	50	ms
$T_{MGTAVTT}$	Ramp time from GND to 90% of $V_{MGTAVTT}$		0.2	50	ms
$T_{MGTVCCAUX}$	Ramp time from GND to 90% of $V_{MGTVCCAUX}$		0.2	50	ms

**Notes:**

1. Based on 240,000 power cycles with nominal  $V_{CCO}$  of 3.3V or 36,500 power cycles with a worst case  $V_{CCO}$  of 3.465V.

## AC Switching Characteristics

All values represented in this data sheet are based on the speed specifications in ISE® software 14.3 v1.07 for the -3, -2, -2L(1.0V), -1, and v1.06 for -2L(0.9V) speed grades.

Switching characteristics are specified on a per-speed-grade basis and can be designated as Advance, Preliminary, or Production. Each designation is defined as follows:

### ***Advance Product Specification***

These specifications are based on simulations only and are typically available soon after device design specifications are frozen. Although speed grades with this designation are considered relatively stable and conservative, some under-reporting might still occur.

### ***Preliminary Product Specification***

These specifications are based on complete ES (engineering sample) silicon characterization. Devices and speed grades with this designation are intended to give a better indication of the expected performance of production silicon. The probability of under-reporting delays is greatly reduced as compared to Advance data.

### ***Product Specification***

These specifications are released once enough production silicon of a particular device family member has been characterized to provide full correlation between specifications and devices over numerous production lots. There is no under-reporting of delays, and customers receive formal notification of any subsequent changes. Typically, the slowest speed grades transition to production before faster speed grades.

## Testing of AC Switching Characteristics

Internal timing parameters are derived from measuring internal test patterns. All AC switching characteristics are representative of worst-case supply voltage and junction temperature conditions.

For more specific, more precise, and worst-case guaranteed data, use the values reported by the static timing analyzer and back-annotate to the simulation net list. Unless otherwise noted, values apply to all Kintex-7 FPGAs.

## Speed Grade Designations

Since individual family members are produced at different times, the migration from one category to another depends completely on the status of the fabrication process for each device. [Table 14](#) correlates the current status of each Kintex-7 device on a per speed grade basis.

**Table 14: Kintex-7 Device Speed Grade Designations**

Device	Speed Grade Designations		
	Advance	Preliminary	Production
XC7K70T			-3, -2, -2L(1.0V), -1, and -2L (0.9V)
XC7K160T			-3, -2, -2L(1.0V), -1, and -2L (0.9V)
XC7K325T			-3, -2, -2L(1.0V), -1, and -2L (0.9V)
XC7K355T			-3, -2, -2L(1.0V), -1, and -2L (0.9V)
XC7K410T			-3, -2, -2L(1.0V), -1, and -2L (0.9V)
XC7K420T			-3, -2, -2L(1.0V), -1, and -2L (0.9V)
XC7K480T			-3, -2, -2L(1.0V), -1, and -2L (0.9V)

## Production Silicon and ISE Software Status

In some cases, a particular family member (and speed grade) is released to production before a speed specification is released with the correct label (Advance, Preliminary, Production). Any labeling discrepancies are corrected in subsequent speed specification releases.

**Table 15** lists the production released Kintex-7 device, speed grade, and the minimum corresponding supported speed specification version and ISE software revisions. The ISE software and speed specifications listed are the minimum releases required for production. All subsequent releases of software and speed specifications are valid.

**Table 15: Kintex-7 Device Production Software and Speed Specification Release**

Device	Speed Grade Designations			
	1.0V		0.9V	
	-3	-2/-2L	-1	-2L
XC7K70T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K160T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K325T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K355T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K410T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K420T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K480T		ISE 14.2 v1.06		ISE 14.3 v1.06

## Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Kintex-7 devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the [AC Switching Characteristics, page 11](#). In each table, the I/O bank type is either High Performance (HP) or High Range (HR).

**Table 16: Networking Applications Interface Performances**

Description	I/O Bank Type	Speed Grade				Units	
		1.0V		0.9V			
		-3	-2/-2L	-1	-2L		
SDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 8)	HR	710	710	625	625	Mb/s	
	HP	710	710	625	625	Mb/s	
DDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 14)	HR	1250	1250	950	950	Mb/s	
	HP	1600	1400	1250	1250	Mb/s	
SDR LVDS receiver (SFI-4.1) <sup>(1)</sup>	HR	710	710	625	625	Mb/s	
	HP	710	710	625	625	Mb/s	
DDR LVDS receiver (SPI-4.2) <sup>(1)</sup>	HR	1250	1250	950	950	Mb/s	
	HP	1600	1400	1250	1250	Mb/s	

### Notes:

- LVDS receivers are typically bounded with certain applications where specific dynamic phase-alignment (DPA) algorithms dominate deterministic performance.

Table 17: Maximum Physical Interface (PHY) Rate for Memory Interfaces (FFG Packages)<sup>(1)(2)</sup>

Memory Standard	I/O Bank Type	V <sub>CCAUX_IO</sub>	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
<b>4:1 Memory Controllers</b>							
DDR3	HP	2.0V	1866	1866	1600	1333	Mb/s
	HP	1.8V	1600	1333	1066	1066	Mb/s
	HR	N/A	1066	1066	800	800	Mb/s
DDR3L	HP	2.0V	1600	1600	1333	1066	Mb/s
	HP	1.8V	1333	1066	800	800	Mb/s
	HR	N/A	800	800	667	667	Mb/s
DDR2	HP	2.0V	800	800	800	800	Mb/s
	HP	1.8V	800	800	800	800	Mb/s
	HR	N/A	800	800	800	800	Mb/s
RLDRAM III <sup>(3)</sup>	HP	2.0V	800	667	667	533	MHz
	HP	1.8V	550	500	450	450	MHz
	HR	N/A			N/A		
<b>2:1 Memory Controllers</b>							
DDR3	HP	2.0V	1066	1066	800	800	Mb/s
	HP	1.8V	1066	1066	800	800	Mb/s
	HR	N/A	1066	1066	800	800	Mb/s
DDR3L	HP	2.0V	1066	1066	800	800	Mb/s
	HP	1.8V	1066	1066	800	800	Mb/s
	HR	N/A	800	800	667	667	Mb/s
DDR2	HP	2.0V	800	800	800	800	Mb/s
	HP	1.8V					
	HR	N/A					
QDR II+ <sup>(4)</sup>	HP	2.0V	550	500	450	450	MHz
	HP	1.8V					
	HR	N/A					
RLDRAM II	HP	2.0V	533	500	450	450	MHz
	HP	1.8V					
	HR	N/A					
LPDDR2 <sup>(3)</sup>	HP	2.0V	800	800	800	800	Mb/s
	HP	1.8V	800	800	800	800	Mb/s
	HR	N/A	800	667	667	667	Mb/s

**Notes:**

1. V<sub>REF</sub> tracking is required. For more information, see [UG586, 7 Series FPGAs Memory Interface Solutions User Guide](#).
2. When using the internal V<sub>REF</sub> the maximum data rate is 800 Mb/s (400 MHz).
3. RLDRAM III (BL = 4, BL = 8) and LPDDR2 specifications have not been validated with memory IP.
4. The maximum QDRII+ performance specifications are for burst-length 4 (BL = 4) implementations. Burst length 2 (BL = 2) implementations are limited to 333 MHz for all speed grades and I/O bank types.

Table 19: 3.3V IOB High Range (HR) Switching Characteristics (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V			
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L		
HSTL_I_F	0.61	0.64	0.73	0.79	1.10	1.19	1.23	1.41	1.86	2.05	2.22	1.92	ns	
HSTL_II_F	0.61	0.64	0.73	0.78	1.05	1.18	1.28	1.42	1.81	2.04	2.27	1.94	ns	
HSTL_I_18_F	0.64	0.67	0.76	0.79	1.05	1.18	1.28	1.44	1.81	2.04	2.27	1.95	ns	
HSTL_II_18_F	0.64	0.67	0.76	0.79	1.03	1.14	1.23	1.42	1.79	2.00	2.22	1.94	ns	
DIFF_HSTL_I_F	0.63	0.67	0.77	0.78	1.09	1.18	1.22	1.48	1.85	2.04	2.21	2.00	ns	
DIFF_HSTL_II_F	0.63	0.67	0.77	0.79	1.02	1.11	1.14	1.48	1.78	1.97	2.13	2.00	ns	
DIFF_HSTL_I_18_F	0.65	0.69	0.78	0.79	1.08	1.17	1.21	1.48	1.84	2.03	2.20	2.00	ns	
DIFF_HSTL_II_18_F	0.65	0.69	0.78	0.81	1.01	1.10	1.13	1.48	1.77	1.96	2.12	2.00	ns	
LVCMOS33_S4	1.31	1.40	1.60	1.54	5.23	5.61	6.09	4.13	5.99	6.47	7.08	4.64	ns	
LVCMOS33_S8	1.31	1.40	1.60	1.54	4.46	4.85	5.33	3.84	5.22	5.71	6.32	4.36	ns	
LVCMOS33_S12	1.31	1.40	1.60	1.54	3.46	3.89	4.42	3.41	4.22	4.75	5.41	3.92	ns	
LVCMOS33_S16	1.31	1.40	1.60	1.54	3.06	3.43	3.88	3.72	3.82	4.29	4.87	4.23	ns	
LVCMOS33_F4	1.31	1.40	1.60	1.54	4.70	5.01	5.36	3.58	5.46	5.87	6.35	4.09	ns	
LVCMOS33_F8	1.31	1.40	1.60	1.54	3.62	4.04	4.56	3.06	4.38	4.90	5.55	3.58	ns	
LVCMOS33_F12	1.31	1.40	1.60	1.54	2.57	2.85	3.15	2.88	3.33	3.71	4.14	3.39	ns	
LVCMOS33_F16	1.31	1.40	1.60	1.54	2.44	2.69	2.96	2.88	3.20	3.55	3.95	3.39	ns	
LVCMOS25_S4	1.08	1.16	1.32	1.36	4.49	4.80	5.16	3.44	5.25	5.66	6.15	3.95	ns	
LVCMOS25_S8	1.08	1.16	1.32	1.36	3.66	4.04	4.49	3.20	4.42	4.90	5.48	3.72	ns	
LVCMOS25_S12	1.08	1.16	1.32	1.36	2.77	3.10	3.49	2.80	3.53	3.96	4.48	3.31	ns	
LVCMOS25_S16	1.08	1.16	1.32	1.36	3.24	3.62	4.09	3.14	4.00	4.48	5.08	3.66	ns	
LVCMOS25_F4	1.08	1.16	1.32	1.36	3.96	4.31	4.72	3.06	4.72	5.17	5.71	3.58	ns	
LVCMOS25_F8	1.08	1.16	1.32	1.36	2.43	2.87	3.42	2.50	3.19	3.73	4.41	3.02	ns	
LVCMOS25_F12	1.08	1.16	1.32	1.36	2.23	2.63	3.13	2.48	2.99	3.49	4.12	3.00	ns	
LVCMOS25_F16	1.08	1.16	1.32	1.36	1.92	2.17	2.45	2.33	2.68	3.03	3.44	2.84	ns	
LVCMOS18_S4	0.64	0.66	0.74	0.87	3.24	3.45	3.66	1.91	4.00	4.31	4.65	2.42	ns	
LVCMOS18_S8	0.64	0.66	0.74	0.87	2.58	2.91	3.31	2.50	3.34	3.77	4.30	3.02	ns	
LVCMOS18_S12	0.64	0.66	0.74	0.87	2.58	2.91	3.31	2.50	3.34	3.77	4.30	3.02	ns	
LVCMOS18_S16	0.64	0.66	0.74	0.87	1.82	2.03	2.24	1.84	2.58	2.89	3.23	2.36	ns	
LVCMOS18_S24 <sup>(1)</sup>	0.64	0.66	0.74	0.87	1.74	1.92	2.08	1.92	2.50	2.78	3.07	2.44	ns	
LVCMOS18_F4	0.64	0.66	0.74	0.87	3.12	3.31	3.49	1.77	3.88	4.17	4.48	2.28	ns	
LVCMOS18_F8	0.64	0.66	0.74	0.87	1.91	2.13	2.36	2.00	2.67	2.99	3.35	2.52	ns	
LVCMOS18_F12	0.64	0.66	0.74	0.87	1.91	2.13	2.36	2.00	2.67	2.99	3.35	2.52	ns	
LVCMOS18_F16	0.64	0.66	0.74	0.87	1.52	1.68	1.81	1.72	2.28	2.54	2.80	2.23	ns	
LVCMOS18_F24 <sup>(1)</sup>	0.64	0.66	0.74	0.87	1.34	1.46	1.55	1.66	2.10	2.32	2.54	2.17	ns	
LVCMOS15_S4	0.66	0.69	0.81	0.90	3.48	3.74	4.03	2.22	4.24	4.60	5.02	2.73	ns	
LVCMOS15_S8	0.66	0.69	0.81	0.90	2.37	2.67	3.01	2.41	3.13	3.53	4.00	2.92	ns	
LVCMOS15_S12	0.66	0.69	0.81	0.90	1.83	2.03	2.23	1.91	2.59	2.89	3.22	2.42	ns	

Table 19: 3.3V IOB High Range (HR) Switching Characteristics (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V			
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L		
LVCMOS15_S16	0.66	0.69	0.81	0.90	1.76	1.95	2.13	1.91	2.52	2.81	3.12	2.42	ns	
LVCMOS15_F4	0.66	0.69	0.81	0.90	3.39	3.60	3.80	1.98	4.15	4.46	4.79	2.50	ns	
LVCMOS15_F8	0.66	0.69	0.81	0.90	1.79	1.99	2.18	1.92	2.55	2.85	3.17	2.44	ns	
LVCMOS15_F12	0.66	0.69	0.81	0.90	1.40	1.54	1.65	1.67	2.16	2.40	2.64	2.19	ns	
LVCMOS15_F16	0.66	0.69	0.81	0.90	1.37	1.51	1.61	1.66	2.13	2.37	2.60	2.17	ns	
LVCMOS12_S4	0.88	0.91	1.00	1.01	3.85	4.22	4.69	2.89	4.61	5.08	5.68	3.41	ns	
LVCMOS12_S8	0.88	0.91	1.00	1.01	2.52	2.96	3.52	2.41	3.28	3.82	4.51	2.92	ns	
LVCMOS12_S12 <sup>(1)</sup>	0.88	0.91	1.00	1.01	2.06	2.31	2.59	2.11	2.82	3.17	3.58	2.63	ns	
LVCMOS12_F4	0.88	0.91	1.00	1.01	3.44	3.73	4.06	2.30	4.20	4.59	5.05	2.81	ns	
LVCMOS12_F8	0.88	0.91	1.00	1.01	1.72	2.04	2.40	1.86	2.48	2.90	3.39	2.38	ns	
LVCMOS12_F12 <sup>(1)</sup>	0.88	0.91	1.00	1.01	1.54	1.71	1.87	1.69	2.30	2.57	2.86	2.20	ns	
SSTL135_S	0.61	0.64	0.73	0.79	1.27	1.40	1.50	1.64	2.03	2.26	2.49	2.16	ns	
SSTL15_S	0.61	0.64	0.73	0.73	1.24	1.37	1.47	1.59	2.00	2.23	2.46	2.11	ns	
SSTL18_I_S	0.64	0.67	0.76	0.79	1.59	1.74	1.85	1.95	2.35	2.60	2.84	2.47	ns	
SSTL18_II_S	0.64	0.67	0.76	0.78	1.27	1.40	1.50	1.63	2.03	2.26	2.49	2.14	ns	
DIFF_SSTL135_S	0.59	0.61	0.73	0.79	1.27	1.40	1.50	1.64	2.03	2.26	2.49	2.16	ns	
DIFF_SSTL15_S	0.63	0.67	0.77	0.79	1.24	1.37	1.47	1.59	2.00	2.23	2.46	2.11	ns	
DIFF_SSTL18_I_S	0.65	0.69	0.78	0.79	1.50	1.63	1.72	1.95	2.26	2.49	2.71	2.47	ns	
DIFF_SSTL18_II_S	0.65	0.69	0.78	0.79	1.13	1.22	1.25	1.66	1.89	2.08	2.24	2.17	ns	
SSTL135_F	0.61	0.64	0.73	0.79	1.04	1.17	1.26	1.42	1.80	2.03	2.25	1.94	ns	
SSTL15_F	0.61	0.64	0.73	0.73	1.04	1.17	1.26	1.39	1.80	2.03	2.25	1.91	ns	
SSTL18_I_F	0.64	0.67	0.76	0.79	1.12	1.22	1.26	1.44	1.88	2.08	2.25	1.95	ns	
SSTL18_II_F	0.64	0.67	0.76	0.78	1.05	1.18	1.28	1.42	1.81	2.04	2.27	1.94	ns	
DIFF_SSTL135_F	0.59	0.61	0.73	0.79	1.04	1.17	1.26	1.42	1.80	2.03	2.25	1.94	ns	
DIFF_SSTL15_F	0.63	0.67	0.77	0.79	1.04	1.17	1.26	1.39	1.80	2.03	2.25	1.91	ns	
DIFF_SSTL18_I_F	0.65	0.69	0.78	0.79	1.10	1.19	1.23	1.52	1.86	2.05	2.22	2.03	ns	
DIFF_SSTL18_II_F	0.65	0.69	0.78	0.79	1.02	1.10	1.14	1.50	1.78	1.96	2.13	2.02	ns	

**Notes:**

- This I/O standard is only available in the 3.3V high-range (HR) banks.

**Table 21** specifies the values of  $T_{IOTPHZ}$  and  $T_{IOIBUFDISABLE}$ .  $T_{IOTPHZ}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is enabled (i.e., a high impedance state).  $T_{IOIBUFDISABLE}$  is described as the IOB delay from IBUFDISABLE to O output. In HP I/O banks, the internal DCI termination turn-off time is always faster than  $T_{IOTPHZ}$  when the DCITERMDISABLE pin is used. In HR I/O banks, the internal IN\_TERM termination turn-off time is always faster than  $T_{IOTPHZ}$  when the INTERMDISABLE pin is used.

Table 21: IOB 3-state Output Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
$T_{IOTPHZ}$	T input to pad high-impedance	0.76	0.86	0.99	0.62	ns
$T_{IOIBUFDISABLE\_HR}$	IBUF turn-on time from IBUFDISABLE to O output for HR I/O banks	1.72	1.89	2.14	2.17	ns
$T_{IOIBUFDISABLE\_HP}$	IBUF turn-on time from IBUFDISABLE to O output for HP I/O banks	1.31	1.46	1.76	1.86	ns

## Input/Output Delay Switching Characteristics

Table 26: Input/Output Delay Switching Characteristics

Symbol	Description	Speed Grade				Units	
		1.0V		0.9V			
		-3	-2/-2L	-1	-2L		
<b>IDELAYCTRL</b>							
T <sub>DLYCCO_RDY</sub>	Reset to Ready for IDELAYCTRL	3.22	3.22	3.22	3.22	μs	
F <sub>IDELAYCTRL_REF</sub>	Attribute REFCLK frequency = 200.00 <sup>(1)</sup>	200.00	200.00	200.00	200.00	MHz	
	Attribute REFCLK frequency = 300.00 <sup>(1)</sup>	300.00	300.00	N/A	N/A	MHz	
IDELAYCTRL_REF_PRECISION	REFCLK precision	±10	±10	±10	±10	MHz	
T <sub>IDELAYCTRL_RPW</sub>	Minimum Reset pulse width	52.00	52.00	52.00	52.00	ns	
<b>IDELAY/ODELAY</b>							
T <sub>IDELAYRESOLUTION</sub>	IDELAY/ODELAY chain delay resolution	1/(32 x 2 x F <sub>REF</sub> )				ps	
T <sub>IDELAYPAT_JIT</sub> and T <sub>ODELAYPAT_JIT</sub>	Pattern dependent period jitter in delay chain for clock pattern. <sup>(2)</sup>	0	0	0	0	ps per tap	
	Pattern dependent period jitter in delay chain for random data pattern (PRBS 23) <sup>(3)</sup>	±5	±5	±5	±5	ps per tap	
	Pattern dependent period jitter in delay chain for random data pattern (PRBS 23) <sup>(4)</sup>	±9	±9	±9	±9	ps per tap	
T <sub>IDELAY_CLK_MAX</sub> /T <sub>ODELAY_CLK_MAX</sub>	Maximum frequency of CLK input to IDELAY/ODELAY	800.00	800.00	710.00	710.00	MHz	
T <sub>IDCCK_CE</sub> / T <sub>IDCKC_CE</sub>	CE pin Setup/Hold with respect to C for IDELAY	0.11/0.10	0.14/0.12	0.18/0.14	0.14/0.16	ns	
T <sub>ODCCK_CE</sub> / T <sub>ODCKC_CE</sub>	CE pin Setup/Hold with respect to C for ODELAY	0.14/0.03	0.16/0.04	0.19/0.05	0.28/0.06	ns	
T <sub>IDCCK_INC</sub> / T <sub>IDCKC_INC</sub>	INC pin Setup/Hold with respect to C for IDELAY	0.10/0.14	0.12/0.16	0.14/0.20	0.10/0.23	ns	
T <sub>ODCCK_INC</sub> / T <sub>ODCKC_INC</sub>	INC pin Setup/Hold with respect to C for ODELAY	0.10/0.07	0.12/0.08	0.13/0.09	0.19/0.16	ns	
T <sub>IDCCK_RST</sub> / T <sub>IDCKC_RST</sub>	RST pin Setup/Hold with respect to C for IDELAY	0.13/0.08	0.14/0.10	0.16/0.12	0.22/0.19	ns	
T <sub>ODCCK_RST</sub> / T <sub>ODCKC_RST</sub>	RST pin Setup/Hold with respect to C for ODELAY	0.16/0.04	0.19/0.06	0.24/0.08	0.32/0.11	ns	
T <sub>IDDO_IDATAIN</sub>	Propagation delay through IDELAY	Note 5	Note 5	Note 5	Note 5	ps	
T <sub>ODDO_ODATAIN</sub>	Propagation delay through ODELAY	Note 5	Note 5	Note 5	Note 5	ps	

**Notes:**

1. Average Tap Delay at 200 MHz = 78 ps, at 300 MHz = 52 ps.
2. When HIGH\_PERFORMANCE mode is set to TRUE or FALSE.
3. When HIGH\_PERFORMANCE mode is set to TRUE.
4. When HIGH\_PERFORMANCE mode is set to FALSE.
5. Delay depends on IDELAY/ODELAY tap setting. See TRACE report for actual values.

Table 27: IO\_FIFO Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>IO_FIFO Clock to Out Delays</b>						
T <sub>OFFCKO_DO</sub>	RDCLK to Q outputs	0.51	0.56	0.63	0.81	ns
T <sub>CKO_FLAGS</sub>	Clock to IO_FIFO Flags	0.59	0.62	0.81	0.77	ns
<b>Setup/Hold</b>						
T <sub>CCK_D/T<sub>CKC_D</sub></sub>	D inputs to WRCLK	0.43/-0.01	0.47/-0.01	0.53/-0.01	0.76/-0.05	ns
T <sub>IFFCCK_WREN/T<sub>IFFCKC_WREN</sub></sub>	WREN to WRCLK	0.39/-0.01	0.43/-0.01	0.50/-0.01	0.70/-0.05	ns
T <sub>OFFCCK_RDEN/T<sub>OFFCKC_RDEN</sub></sub>	RDEN to RDCLK	0.49/0.01	0.53/0.02	0.61/0.02	0.79/-0.02	ns
<b>Minimum Pulse Width</b>						
T <sub>PWH_IO_FIFO</sub>	RESET, RDCLK, WRCLK	0.81	0.92	1.08	1.29	ns
T <sub>PWL_IO_FIFO</sub>	RESET, RDCLK, WRCLK	0.81	0.92	1.08	1.29	ns
<b>Maximum Frequency</b>						
F <sub>MAX</sub>	RDCLK and WRCLK	533.05	470.37	400.00	333.33	MHz

## CLB Switching Characteristics

Table 28: CLB Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Combinatorial Delays</b>						
T <sub>ILO</sub>	An – Dn LUT address to A	0.05	0.05	0.06	0.07	ns, Max
T <sub>ILO_2</sub>	An – Dn LUT address to AMUX/CMUX	0.15	0.16	0.19	0.22	ns, Max
T <sub>ILO_3</sub>	An – Dn LUT address to BMUX_A	0.24	0.25	0.30	0.37	ns, Max
T <sub>I TO</sub>	An – Dn inputs to A – D Q outputs	0.58	0.61	0.74	0.91	ns, Max
T <sub>AXA</sub>	AX inputs to AMUX output	0.38	0.40	0.49	0.62	ns, Max
T <sub>AXB</sub>	AX inputs to BMUX output	0.40	0.42	0.52	0.66	ns, Max
T <sub>AXC</sub>	AX inputs to CMUX output	0.39	0.41	0.50	0.62	ns, Max
T <sub>AXD</sub>	AX inputs to DMUX output	0.43	0.44	0.52	0.67	ns, Max
T <sub>BXB</sub>	BX inputs to BMUX output	0.31	0.33	0.40	0.51	ns, Max
T <sub>BXD</sub>	BX inputs to DMUX output	0.38	0.39	0.47	0.62	ns, Max
T <sub>CXC</sub>	CX inputs to CMUX output	0.27	0.28	0.34	0.43	ns, Max
T <sub>CXD</sub>	CX inputs to DMUX output	0.33	0.34	0.41	0.54	ns, Max
T <sub>DXD</sub>	DX inputs to DMUX output	0.32	0.33	0.40	0.52	ns, Max
<b>Sequential Delays</b>						
T <sub>CKO</sub>	Clock to AQ – DQ outputs	0.26	0.27	0.32	0.40	ns, Max
T <sub>SHCKO</sub>	Clock to AMUX – DMUX outputs	0.32	0.32	0.39	0.46	ns, Max
<b>Setup and Hold Times of CLB Flip-Flops Before/After Clock CLK</b>						
T <sub>AS/T<sub>AH</sub></sub>	A <sub>N</sub> – D <sub>N</sub> input to CLK on A – D Flip Flops	0.01/0.12	0.02/0.13	0.03/0.18	0.02/0.18	ns, Min
T <sub>DICK/T<sub>CKDI</sub></sub>	A <sub>X</sub> – D <sub>X</sub> input to CLK on A – D Flip Flops	0.04/0.14	0.04/0.14	0.05/0.20	0.05/0.21	ns, Min
	A <sub>X</sub> – D <sub>X</sub> input through MUXs and/or carry logic to CLK on A – D Flip Flops	0.36/0.10	0.37/0.11	0.46/0.16	0.56/0.15	ns, Min
T <sub>CECK_CLB/</sub> T <sub>CKCE_CLB</sub>	CE input to CLK on A – D Flip Flops	0.19/0.05	0.20/0.05	0.25/0.05	0.24/0.04	ns, Min
T <sub>SRCK/T<sub>CKSR</sub></sub>	SR input to CLK on A – D Flip Flops	0.30/0.05	0.31/0.07	0.37/0.09	0.48/0.05	ns, Min
<b>Set/Reset</b>						
T <sub>SRMIN</sub>	SR input minimum pulse width	0.52	0.78	1.04	0.95	ns, Min
T <sub>RQ</sub>	Delay from SR input to AQ – DQ flip-flops	0.38	0.38	0.46	0.59	ns, Max
T <sub>CEO</sub>	Delay from CE input to AQ – DQ flip-flops	0.34	0.35	0.43	0.54	ns, Max
F <sub>TOG</sub>	Toggle frequency (for export control)	1818	1818	1818	1286	MHz

Table 32: DSP48E1 Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup and Hold Times of the RST Pins</b>						
$T_{DSPDCK\_RSTA; RSTB\_AREG; BREG}/T_{DSPCKD\_RSTA; RSTB\_AREG; BREG}$	{RSTA, RSTB} input to {A, B} register CLK	0.34/ 0.10	0.39/ 0.11	0.47/ 0.13	0.53/ 0.34	ns
$T_{DSPDCK\_RSTC\_CREG}/T_{DSPCKD\_RSTC\_CREG}$	RSTC input to C register CLK	0.06/ 0.22	0.07/ 0.24	0.08/ 0.26	0.08/ 0.31	ns
$T_{DSPDCK\_RSTD\_DREG}/T_{DSPCKD\_RSTD\_DREG}$	RSTD input to D register CLK	0.37/ 0.06	0.42/ 0.06	0.50/ 0.07	0.57/ 0.07	ns
$T_{DSPDCK\_RSTM\_MREG}/T_{DSPCKD\_RSTM\_MREG}$	RSTM input to M register CLK	0.18/ 0.18	0.20/ 0.21	0.23/ 0.24	0.24/ 0.29	ns
$T_{DSPDCK\_RSTP\_PREG}/T_{DSPCKD\_RSTP\_PREG}$	RSTP input to P register CLK	0.24/ 0.01	0.26/ 0.01	0.30/ 0.01	0.37/ 0.00	ns
<b>Combinatorial Delays from Input Pins to Output Pins</b>						
$T_{DSPDO\_A\_CARRYOUT\_MULT}$	A input to CARRYOUT output using multiplier	3.21	3.69	4.39	5.60	ns
$T_{DSPDO\_D\_P\_MULT}$	D input to P output using multiplier	3.15	3.61	4.30	5.44	ns
$T_{DSPDO\_A\_P}$	A input to P output not using multiplier	1.30	1.48	1.76	2.10	ns
$T_{DSPDO\_C\_P}$	C input to P output	1.13	1.30	1.55	1.84	ns
<b>Combinatorial Delays from Input Pins to Cascading Output Pins</b>						
$T_{DSPDO\_A; B\_ACOUT; BCOUT}$	{A, B} input to {ACOUT, BCOUT} output	0.47	0.53	0.63	0.75	ns
$T_{DSPDO\_A, B\_CARRYCASOUT\_MULT}$	{A, B} input to CARRYCASOUT output using multiplier	3.44	3.94	4.69	5.96	ns
$T_{DSPDO\_D\_CARRYCASOUT\_MULT}$	D input to CARRYCASOUT output using multiplier	3.36	3.85	4.58	5.77	ns
$T_{DSPDO\_A, B\_CARRYCASOUT}$	{A, B} input to CARRYCASOUT output not using multiplier	1.50	1.72	2.04	2.44	ns
$T_{DSPDO\_C\_CARRYCASOUT}$	C input to CARRYCASOUT output	1.34	1.53	1.83	2.18	ns
<b>Combinatorial Delays from Cascading Input Pins to All Output Pins</b>						
$T_{DSPDO\_ACIN\_P\_MULT}$	ACIN input to P output using multiplier	3.09	3.55	4.24	5.42	ns
$T_{DSPDO\_ACIN\_P}$	ACIN input to P output not using multiplier	1.16	1.33	1.59	2.07	ns
$T_{DSPDO\_ACIN\_ACOUT}$	ACIN input to ACOUT output	0.32	0.37	0.45	0.53	ns
$T_{DSPDO\_ACIN\_CARRYCASOUT\_MULT}$	ACIN input to CARRYCASOUT output using multiplier	3.30	3.79	4.52	5.76	ns
$T_{DSPDO\_ACIN\_CARRYCASOUT}$	ACIN input to CARRYCASOUT output not using multiplier	1.37	1.57	1.87	2.40	ns
$T_{DSPDO\_PCIN\_P}$	PCIN input to P output	0.94	1.08	1.29	1.54	ns
$T_{DSPDO\_PCIN\_CARRYCASOUT}$	PCIN input to CARRYCASOUT output	1.15	1.32	1.57	1.88	ns
<b>Clock to Outs from Output Register Clock to Output Pins</b>						
$T_{DSPCKO\_P\_PREG}$	CLK PREG to P output	0.33	0.35	0.39	0.45	ns
$T_{DSPCKO\_CARRYCASOUT\_PREG}$	CLK PREG to CARRYCASOUT output	0.44	0.50	0.59	0.71	ns

## Clock Buffers and Networks

Table 33: Global Clock Switching Characteristics (Including BUFGCTRL)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T_BCCCK_CE/T_BCCKC_CE <sup>(1)</sup>	CE pins Setup/Hold	0.12/0.30	0.14/0.38	0.26/0.38	0.23/0.40	ns
T_BCCCK_S/T_BCCKC_S <sup>(1)</sup>	S pins Setup/Hold	0.12/0.30	0.14/0.38	0.26/0.38	0.23/0.40	ns
T_BGCKO_O <sup>(2)</sup>	BUFGCTRL delay from I0/I1 to O	0.08	0.10	0.12	0.10	ns
<b>Maximum Frequency</b>						
F <sub>MAX_BUFG</sub>	Global clock tree (BUFG)	741.00	710.00	625.00	560.00	MHz

**Notes:**

1. T<sub>BCCCK\_CE</sub> and T<sub>BCCKC\_CE</sub> must be satisfied to assure glitch-free operation of the global clock when switching between clocks. These parameters do not apply to the BUFGMUX primitive that assures glitch-free operation. The other global clock setup and hold times are optional; only needing to be satisfied if device operation requires simulation matches on a cycle-for-cycle basis when switching between clocks.
2. T<sub>BGCKO\_O</sub> (BUFG delay from I0 to O) values are the same as T<sub>BCCKO\_O</sub> values.

Table 34: Input/Output Clock Switching Characteristics (BUFIO)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T_BLOCKO_O	Clock to out delay from I to O	1.04	1.14	1.32	1.48	ns
<b>Maximum Frequency</b>						
F <sub>MAX_BUFIO</sub>	I/O clock tree (BUFIO)	800.00	800.00	710.00	710.00	MHz

Table 35: Regional Clock Buffer Switching Characteristics (BUFR)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T_BRCKO_O	Clock to out delay from I to O	0.60	0.65	0.77	1.06	ns
T_BRCKO_O_BYP	Clock to out delay from I to O with Divide Bypass attribute set	0.30	0.32	0.38	0.57	ns
T_BRDO_O	Propagation delay from CLR to O	0.71	0.75	0.96	0.93	ns
<b>Maximum Frequency</b>						
F <sub>MAX_BUFR</sub> <sup>(1)</sup>	Regional clock tree (BUFR)	600.00	540.00	450.00	450.00	MHz

**Notes:**

1. The maximum input frequency to the BUFR is the BUFIO F<sub>MAX</sub> frequency.

## Device Pin-to-Pin Input Parameter Guidelines

All devices are 100% functionally tested. Values are expressed in nanoseconds unless otherwise noted.

**Table 45: Global Clock Input Setup and Hold Without MMCM/PLL with ZHOLD\_DELAY on HR I/O Banks**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
Input Setup and Hold Time Relative to Global Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>								
$T_{PSFD}/T_{PHFD}$	Full Delay (Legacy Delay or Default Delay) Global Clock Input and IFF <sup>(2)</sup> without MMCM/PLL with ZHOLD_DELAY on HR I/O Banks	XC7K70T	2.83/-0.29	2.95/-0.29	3.15/-0.29	4.96/-0.33	ns	
		XC7K160T	3.17/-0.35	3.29/-0.35	3.55/-0.35	5.54/-0.49	ns	
		XC7K325T	2.83/-0.06	2.94/-0.06	3.15/-0.06	5.18/-0.14	ns	
		XC7K355T	3.26/-0.32	3.41/-0.32	3.67/-0.32	5.84/-0.49	ns	
		XC7K410T	3.43/-0.34	3.59/-0.34	3.88/-0.34	6.21/-0.54	ns	
		XC7K420T	3.37/-0.27	3.48/-0.27	3.76/-0.27	6.00/-0.52	ns	
		XC7K480T	3.37/-0.27	3.48/-0.27	3.76/-0.27	6.00/-0.52	ns	

### Notes:

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. A Zero "0" Hold Time listing indicates no hold time or a negative hold time.

**Table 46: Clock-Capable Clock Input Setup and Hold With MMCM**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
Input Setup and Hold Time Relative to Global Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>								
$T_{PSMMCMCC}/T_{PHMMCMCC}$	No Delay clock-capable clock input and IFF <sup>(2)</sup> with MMCM	XC7K70T	2.39/-0.22	2.65/-0.22	2.94/-0.22	2.21/-0.44	ns	
		XC7K160T	2.49/-0.20	2.77/-0.20	3.07/-0.20	2.38/-0.47	ns	
		XC7K325T	2.55/-0.16	2.85/-0.16	3.14/-0.16	2.60/-0.47	ns	
		XC7K355T	2.43/-0.16	2.73/-0.16	3.00/-0.16	2.47/-0.43	ns	
		XC7K410T	2.55/-0.16	2.84/-0.16	3.14/-0.16	2.58/-0.47	ns	
		XC7K420T	2.47/-0.09	2.73/-0.09	3.02/-0.09	2.40/-0.41	ns	
		XC7K480T	2.47/-0.09	2.73/-0.09	3.02/-0.09	2.40/-0.41	ns	

### Notes:

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 47: Clock-Capable Clock Input Setup and Hold With PLL

Symbol	Description	Device	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
Input Setup and Hold Time Relative to Clock-Capable Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>							
$T_{PSPLLCC}/T_{PHPLLCC}$	No Delay clock-capable clock input and IFF <sup>(2)</sup> with PLL	XC7K70T	2.75/-0.32	3.04/-0.32	3.33/-0.32	2.42/-0.54	ns
		XC7K160T	2.85/-0.31	3.16/-0.31	3.46/-0.31	2.59/-0.56	ns
		XC7K325T	2.91/-0.27	3.24/-0.27	3.54/-0.27	2.80/-0.56	ns
		XC7K355T	2.79/-0.27	3.12/-0.27	3.40/-0.27	2.67/-0.52	ns
		XC7K410T	2.91/-0.27	3.24/-0.27	3.53/-0.27	2.78/-0.56	ns
		XC7K420T	2.83/-0.20	3.12/-0.20	3.41/-0.20	2.61/-0.50	ns
		XC7K480T	2.83/-0.20	3.12/-0.20	3.41/-0.20	2.61/-0.50	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 48: Data Input Setup and Hold Times Relative to a Forwarded Clock Input Pin Using BUFIN

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
Input Setup and Hold Time Relative to a Forwarded Clock Input Pin Using BUFIN for SSTL15 Standard.						
$T_{PSCS}/T_{PHCS}$	Setup/Hold of I/O clock for HR I/O banks	-0.36/1.36	-0.36/1.50	-0.36/1.70	-0.44/1.87	ns
	Setup/Hold of I/O clock for HP I/O banks	-0.34/1.39	-0.34/1.53	-0.34/1.73	-0.44/1.87	ns

Table 49: Sample Window

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
$T_{SAMP}$	Sampling Error at Receiver Pins <sup>(1)</sup>	0.51	0.56	0.61	0.56	ns
$T_{SAMP\_BUFIN}$	Sampling Error at Receiver Pins using BUFIN <sup>(2)</sup>	0.30	0.35	0.40	0.35	ns

**Notes:**

1. This parameter indicates the total sampling error of the Kintex-7 FPGAs DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the MMCM to capture the DDR input registers' edges of operation. These measurements include:
  - CLK0 MMCM jitter
  - MMCM accuracy (phase offset)
  - MMCM phase shift resolution
These measurements do not include package or clock tree skew.
2. This parameter indicates the total sampling error of the Kintex-7 FPGAs DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the BUFIN clock network and IDELAY to capture the DDR input registers' edges of operation. These measurements do not include package or clock tree skew.

## Additional Package Parameter Guidelines

The parameters in this section provide the necessary values for calculating timing budgets for Kintex-7 FPGA clock transmitter and receiver data-valid windows.

*Table 50: Package Skew*

Symbol	Description	Device	Package	Value	Units
$T_{PKGSKEW}$	Package Skew <sup>(1)</sup>	XC7K70T	FBG484	108	ps
			FBG676	135	ps
		XC7K160T	FBG484	118	ps
			FBG676	136	ps
			FFG676	161	ps
		XC7K325T	FBG676	146	ps
			FFG676	154	ps
			FBG900	163	ps
			FFG900	161	ps
		XC7K355T	FFG901	149	ps
		XC7K410T	FBG676	165	ps
			FFG676	168	ps
			FBG900	151	ps
			FFG900	146	ps
		XC7K420T	FFG901	149	ps
			FFG1156	145	ps
		XC7K480T	FFG901	149	ps
			FFG1156	145	ps

**Notes:**

1. These values represent the worst-case skew between any two SelectIO resources in the package: shortest delay to longest delay from die pad to ball.
2. Package delay information is available for these device/package combinations. This information can be used to deskew the package.

**Table 65: CPRI Protocol Characteristics**

Description	Line Rate (Mb/s)	Min	Max	Units
<b>CPRI Transmitter Jitter Generation</b>				
Total transmitter jitter	614.4	–	0.35	UI
	1228.8	–	0.35	UI
	2457.6	–	0.35	UI
	3072.0	–	0.35	UI
	4915.2	–	0.3	UI
	6144.0	–	0.3	UI
	9830.4	–	Note 1	UI
<b>CPRI Receiver Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	614.4	0.65	–	UI
	1228.8	0.65	–	UI
	2457.6	0.65	–	UI
	3072.0	0.65	–	UI
	4915.2	0.95	–	UI
	6144.0	0.95	–	UI
	9830.4	Note 1	–	UI

**Notes:**

- Tested per SFP+ specification, see [Table 64](#).

**Integrated Interface Block for PCI Express Designs Switching Characteristics**

More information and documentation on solutions for PCI Express designs can be found at:

<http://www.xilinx.com/technology/protocols/pciexpress.htm>

**Table 66: Maximum Performance for PCI Express Designs**

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
FPIPECLK	Pipe clock maximum frequency	250.00	250.00	250.00	250.00	MHz
FUSERCLK	User clock maximum frequency	500.00	500.00	250.00	250.00	MHz
FUSERCLK2	User clock 2 maximum frequency	250.00	250.00	250.00	250.00	MHz
FRPCLK	DRP clock maximum frequency	250.00	250.00	250.00	250.00	MHz

Table 67: XADC Specifications (Cont'd)

Parameter	Symbol	Comments/Conditions	Min	Typ	Max	Units
<b>XADC Reference<sup>(5)</sup></b>						
External Reference	V <sub>REFP</sub>	Externally supplied reference voltage	1.20	1.25	1.30	V
On-Chip Reference		Ground V <sub>REFP</sub> pin to AGND, T <sub>j</sub> = -40°C to 100°C	1.2375	1.25	1.2625	V

**Notes:**

- Offset and gain errors are removed by enabling the XADC automatic gain calibration feature. The values are specified for when this feature is enabled.
- Only specified for new BitGen option XADCEnhancedLinearity = ON.
- See the ADC chapter in [UG480: 7 Series FPGAs XADC User Guide](#) for a detailed description.
- See the Timing chapter in [UG480: 7 Series FPGAs XADC User Guide](#) for a detailed description.
- Any variation in the reference voltage from the nominal V<sub>REFP</sub> = 1.25V and V<sub>REFN</sub> = 0V will result in a deviation from the ideal transfer function. This also impacts the accuracy of the internal sensor measurements (i.e., temperature and power supply). However, for external ratiometric type applications allowing reference to vary by ±4% is permitted. On-chip reference variation is ±1%.

## Configuration Switching Characteristics

Table 68: Configuration Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Power-up Timing Characteristics</b>						
T <sub>PL</sub> <sup>(1)</sup>	Program latency	5	5	5	5	ms, Max
T <sub>POR</sub> <sup>(1)</sup>	Power-on reset (50 ms ramp rate time)	10/50	10/50	10/50	10/50	ms, Min/Max
	Power-on reset (1 ms ramp rate time)	10/35	10/35	10/35	10/35	ms, Min/Max
T <sub>PROGRAM</sub>	Program pulse width	250	250	250	250	ns, Min
<b>CCLK Output (Master Mode)</b>						
T <sub>ICCK</sub>	Master CCLK output delay	150	150	150	150	ns, Min
T <sub>MCCKL</sub>	Master CCLK clock Low time duty cycle	40/60	40/60	40/60	40/60	%, Min/Max
T <sub>MCCKH</sub>	Master CCLK clock High time duty cycle	40/60	40/60	40/60	40/60	%, Min/Max
F <sub>MCCCK</sub>	Master CCLK frequency	100.00	100.00	100.00	70.00	MHz, Max
	Master CCLK frequency for AES encrypted x16	50.00	50.00	50.00	35.00	MHz, Max
F <sub>MCCK_START</sub>	Master CCLK frequency at start of configuration	3.00	3.00	3.00	3.00	MHz, Typ
F <sub>MCCKTOL</sub>	Frequency tolerance, master mode with respect to nominal CCLK	±50	±50	±50	±50	%, Max
<b>CCLK Input (Slave Modes)</b>						
T <sub>SCCKL</sub>	Slave CCLK clock minimum Low time	2.50	2.50	2.50	2.50	ns, Min
T <sub>SCCKH</sub>	Slave CCLK clock minimum High time	2.50	2.50	2.50	2.50	ns, Min
F <sub>SCCK</sub>	Slave CCLK frequency	100.00	100.00	100.00	70.00	MHz, Max
<b>EMCCLK Input (Master Mode)</b>						
T <sub>EMCCKL</sub>	External master CCLK Low time	2.50	2.50	2.50	2.50	ns, Min
T <sub>EMCCKH</sub>	External master CCLK High time	2.50	2.50	2.50	2.50	ns, Min
F <sub>EMCCK</sub>	External master CCLK frequency	100.00	100.00	100.00	70.00	MHz, Max
<b>Internal Configuration Access Port</b>						
F <sub>ICAPCK</sub>	Internal configuration access port (ICAPE2)	100.00	100.00	100.00	70.00	MHz, Max

## Revision History

The following table shows the revision history for this document:

Date	Version	Description
03/01/11	1.0	Initial Xilinx release.
04/01/11	1.1	Added the XC7K355T, XC7K420T, and XC7K480T devices throughout data sheet. Added the extended temperature range discussion to <a href="#">page 1</a> . Updated $V_{CCAUX\_IO}$ in <a href="#">Table 2</a> . Edits to clarify <a href="#">Power-On/Off Power Supply Sequencing</a> power sequencing discussion. Added $I_{CCAUX\_IO}$ and $I_{CCBRAM}$ to <a href="#">Table 6</a> and <a href="#">Table 7</a> . Updated MMCM_ $F_{INDUTY}$ and added $F_{INJITTER}$ , $T_{OUTJITTER}$ , $T_{EXTFDVAR}$ , and <a href="#">Note 3</a> to <a href="#">Table 38</a> . Removed the SBG324 package from <a href="#">Table 50</a> . Updated the <a href="#">Notice of Disclaimer</a> .
10/04/11	1.2	Replaced -1L with -2L throughout this data sheet. Updated Min/Max values and removed Note 5 from <a href="#">Table 2</a> . Clarified <a href="#">Power-On/Off Power Supply Sequencing</a> power sequencing discussion including adding $T_{VCO2VCCAUX}$ to <a href="#">Table 8</a> . Updated $V_{ICM}$ in <a href="#">Table 12</a> and <a href="#">Table 13</a> . Added Note 1 to table 12. Updated <a href="#">Table 69</a> including adding <a href="#">Note 1</a> . Added <i>Absolute Maximum Ratings for GTX Transceivers</i> . Revised the reference clock maximum frequency ( $F_{GCLK}$ ) in <a href="#">Table 55</a> . Added <a href="#">Table 57</a> . Added LVTTL and removed SSTL135_II and SSTL15_II specifications from <a href="#">Table 19</a> . Removed HSTL_III from <a href="#">Table 20</a> . Removed the <i>I/O Standard Adjustment Measurement Methodology</i> section. Use IBIS for more accurate information and measurements. Updated $T_{IDELAYPAT\_JIT}$ in <a href="#">Table 26</a> . Added $T_{AS}/T_{AH}$ to <a href="#">Table 28</a> . Added $T_{RDCK\_DI\_WF\_NC}/T_{RCKD\_DI\_WF\_NC}$ and $T_{RDCK\_DI\_RF}/T_{RCKD\_DI\_RF}$ to <a href="#">Table 31</a> . Completely updated <a href="#">Table 68</a> . Updated the <a href="#">AC Switching Characteristics</a> in <a href="#">Table 19</a> , <a href="#">Table 20</a> , <a href="#">Table 21</a> , <a href="#">Table 22</a> , <a href="#">Table 23</a> , <a href="#">Table 24</a> , <a href="#">Table 26</a> through <a href="#">Table 38</a> , <a href="#">Table 40</a> though <a href="#">Table 37</a> , and <a href="#">Table 67</a> .
11/03/11	1.3	Revised the $V_{OCM}$ specification in <a href="#">Table 12</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 13.3 v1.02 speed specification throughout document including <a href="#">Table 19</a> and <a href="#">Table 20</a> . Added MMCM_ $T_{FBDELAY}$ while adding MMCM_ to the symbol names of a few specifications in <a href="#">Table 38</a> and PLL to the symbol names in <a href="#">Table 39</a> . In <a href="#">Table 40</a> through <a href="#">Table 47</a> , updated the pin-to-pin descriptions with the SSTL15 standard. Updated units in <a href="#">Table 49</a> .
02/13/12	1.4	Updated summary description on <a href="#">page 1</a> . In <a href="#">Table 2</a> , revised $V_{CCO}$ for the 3.3V HR I/O banks and updated $T_j$ . Added typical values to <a href="#">Table 3</a> . Updated the notes in <a href="#">Table 6</a> . Added MGTAVCC, MGTAVTT, and MGTVCCAUX power supply ramp times to <a href="#">Table 8</a> . Rearranged <a href="#">Table 9</a> , added Mobile_DDR, HSTL_I_18, HSTL_II_18, HSUL_12, SSTL135_R, SSTL15_R, and SSTL12 and removed DIFF_SSTL135, DIFF_SSTL18_I, DIFF_SSTL18_II, DIFF_HSTL_I, and DIFF_HSTL_II. Added <a href="#">Table 10</a> and <a href="#">Table 11</a> . Revised the specifications in <a href="#">Table 12</a> and <a href="#">Table 13</a> . Updated the <a href="#">eFUSE Programming Conditions</a> section and removed the endurance table. Added the <a href="#">IO_FIFO</a> <a href="#">Switching Characteristics</a> table. Revised $I_{CCADC}$ and updated <a href="#">Note 1</a> in <a href="#">Table 67</a> . Revised DDR LVDS transmitter data width in <a href="#">Table 16</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 13.4 v1.03 speed specification throughout document. Removed notes from <a href="#">Table 28</a> as they are no longer applicable. Updated specifications in <a href="#">Table 68</a> . Updated <a href="#">Note 1</a> in <a href="#">Table 37</a> . In the <a href="#">GTX Transceiver DC Input and Output Levels</a> section: Revised $V_{IN}$ , and added $I_{DCIN}$ and $I_{DCOUT}$ to <a href="#">Table 51</a> . Added <a href="#">Note 4</a> to <a href="#">Table 53</a> . In <a href="#">Table 55</a> , revised $F_{GCLK}$ , removed $T_{PHASE}$ , and added $T_{DLOCK}$ . Revised specifications and added <a href="#">Note 2</a> to <a href="#">Table 57</a> . Added <a href="#">Table 58</a> and <a href="#">Table 59</a> along with <a href="#">GTX Transceiver Protocol Jitter Characteristics</a> in <a href="#">Table 60</a> through <a href="#">Table 65</a> .
05/23/12	1.5	Reorganized entire data sheet including adding <a href="#">Table 44</a> and <a href="#">Table 48</a> . Updated $T_{SOL}$ in <a href="#">Table 1</a> . Updated $I_{BATT}$ and added $R_{IN\_TERM}$ to <a href="#">Table 3</a> . Added values to <a href="#">Table 6</a> and <a href="#">Table 7</a> . Updated <a href="#">Power-On/Off Power Supply Sequencing</a> , <a href="#">page 6</a> with regards to GTX transceivers. Updated many parameters in <a href="#">Table 9</a> including SSTL135 and SSTL135_R. Removed $V_{OX}$ column and added DIFF_HSUL_12 to <a href="#">Table 11</a> . Updated $V_{OL}$ in <a href="#">Table 12</a> . Updated <a href="#">Table 16</a> and removed notes 2 and 3. Updated <a href="#">Table 17</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 14.1 v1.04 for the -3, -2, -2L (1.0V), -1, and -2L (0.9V) speed specifications throughout the document. In <a href="#">Table 31</a> , updated <a href="#">Reset Delays</a> section including <a href="#">Note 10</a> and <a href="#">Note 11</a> . Added data for $T_{LOCK}$ and $T_{DLOCK}$ in <a href="#">Table 55</a> . Updated many of the XADC specifications in <a href="#">Table 67</a> and added <a href="#">Note 2</a> . Updated and moved <i>Dynamic Reconfiguration Port (DRP) for MMCM Before and After DCLK</i> section from <a href="#">Table 68</a> to <a href="#">Table 38</a> and <a href="#">Table 39</a> .

Date	Version	Description
07/25/12	1.6	<p>Updated the descriptions, changed <math>V_{IN}</math> and <a href="#">Note 2</a> and added <a href="#">Note 4</a> in <a href="#">Table 1</a>. In <a href="#">Table 2</a>, changed descriptions and notes, removed Note 7, changed GTX transceiver parameters and values and added <a href="#">Note 9</a>. Updated parameters in <a href="#">Table 3</a>. Added <a href="#">Table 4</a> and <a href="#">Table 5</a>.</p> <p>Changed the typical values for many of the devices in <a href="#">Table 7</a>. Updated LVCMOS12 and the SSTLs in <a href="#">Table 9</a>. Updated many of the specifications in <a href="#">Table 10</a> and <a href="#">Table 11</a>.</p> <p>Updated speed specification to v1.06 (-3, -2, -2L(1.0V), -1) and v1.05 (-2L(0.9V)) with appropriate changes to <a href="#">Table 14</a> and <a href="#">Table 15</a> including production release of the XC7K325T and the XC7K410T in the -2, -2L(1.0V), and -1 speed designations.</p> <p>Added notes and specifications to <a href="#">Table 17</a> and <a href="#">Table 18</a>.</p> <p>Updated the <a href="#">IOB Pad Input/Output/3-State</a> discussion and changed <a href="#">Table 21</a> by adding <math>T_{IOIBUFDISABLE}</math>.</p> <p>Removed many of the combinatorial delay specifications and <math>T_{CINCK}/T_{CKCIN}</math> from <a href="#">Table 28</a>.</p> <p>Rearranged <a href="#">Table 51</a> including moving some parameters to <a href="#">Table 1</a>. Added <a href="#">Table 56</a>. Updated <a href="#">Table 57</a>. In <a href="#">Table 59</a>, updated SJ Jitter Tolerance with Stressed Eye section, <a href="#">page 51</a> and <a href="#">Note 8</a>.</p> <p>Added <a href="#">Note 1</a>, <a href="#">Note 2</a>, and <a href="#">Note 3</a> to <a href="#">Table 62</a>. Added <a href="#">Note 1</a> and <a href="#">Note 2</a> to <a href="#">Table 63</a>, and line rate ranges. Updated <a href="#">Table 64</a> including adding <a href="#">Note 1</a>. Updated <a href="#">Table 65</a> including adding <a href="#">Note 1</a>.</p> <p>In <a href="#">Table 67</a> updated <a href="#">Note 1</a> and added Note 4. In <a href="#">Table 68</a>, updated <math>T_{POR}</math> and <math>F_{EMCCK}</math>.</p>
09/04/12	1.7	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K160T in the -2, -2L(1.0V), and -1 speed designations.
09/26/12	1.8	In <a href="#">Table 2</a> , revised $V_{CCINT}$ and $V_{CCBRAM}$ and added <a href="#">Note 2</a> . Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K480T in the -2, -2L(1.0V), and -1 speed designations and the XC7K325T and XC7K410T in the -3 speed designation.
10/10/12	1.9	Updated the $I_{CCINTMIN}$ value for the XC7K355T in <a href="#">Table 7</a> . Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K420T in the -2, -2L(1.0V), and -1 speed designations.
10/25/12	2.0	<p>Updated the <a href="#">AC Switching Characteristics</a> based upon ISE 14.3 v1.07 for the -3, -2, -2L (1.0V), -1 speed specifications, and ISE 14.3 v1.06 for the -2L (0.9V) speed specifications throughout the document.</p> <p>Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K355T in the -2, -2L(1.0V), and -1 speed designations. Also updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K325T and XC7K410T in the -2L (0.9V).</p> <p>Added values for <a href="#">Table 16</a> -2L (0.9V). Added package skew values to <a href="#">Table 50</a>. In <a href="#">Table 53</a>, increased -1 speed grade (FF package) <math>F_{GTXMAX}</math> value from 6.6 Gb/s to 8.0 Gb/s.</p>
10/31/12	2.1	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K70T in the -2, -2L(1.0V), and -1 speed designations.
11/26/12	2.2	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of -3 speed designation for XC7K70T, XC7K160T, XC7K355T, XC7K420T, and XC7K480T. Removed Note 4 from <a href="#">Table 67</a> .
12/05/12	2.3	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the -2L (0.9V) speed designation for XC7K160T, XC7K420T, and XC7K480T. Updated <a href="#">Note 1</a> in <a href="#">Table 50</a> .
12/12/12	2.4	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the -2L (0.9V) speed designation for XC7K70T and XC7K355T. Added <a href="#">Internal Configuration Access Port</a> section to <a href="#">Table 68</a> .